

<b>Notice of References Cited</b>	Application/Control No. 10/787,502	Applicant(s)/Patent Under Reexamination SAITOU ET AL.	
	Examiner Blane J. Jackson	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,810,274	10-2004	Sawada et al.	455/572
*	B	US-6,999,797	02-2006	Crawford et al.	455/564
*	C	US-2001/0029192	10-2001	Oh, Seung-Hwan	455/556
*	D	US-2003/0153356	08-2003	Liu, Shih-Yuan	455/558
*	E	US-5,487,099	01-1996	Maekawa, Hitoshi	455/556.1
*	F	US-6,738,648	05-2004	Delacourte, Bruno	455/572
*	G	US-6,766,952	07-2004	Luu, Daniel V. H.	235/451
*	H	US-7,039,437	05-2006	Kojola et al.	455/550.1
*	I	US-2005/0107117	05-2005	Makino, Masami	455/556.1
*	J	US-6,731,952	05-2004	Schaeffer et al.	455/557
*	K	US-6,931,266	08-2005	Miyoshi et al.	455/572
*	L	US-6,915,140	07-2005	Silverbrook, Kia	455/550.1
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.